					Application	/Control No	Applicant(s)/F	Patent Under	
			.		Application/Control No. 10/501,228		Reexamination	Reexamination ONOI ET AL.	
Notice of References Cited					Examiner		Art Unit	D44	
					Ling-Siu Choi 1713			Page 1 of 1	
			 .	U.S. PA	ATENT DOCU	MENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name				Classification	
	Α	US-6,653,409	11-2003	Ashiura	Ashiura et al.			525/332.8	
	В	US-2003/0139536	07-2003	Bertin e	Bertin et al.			525/377	
	C -	US-5,610,250	03-1997	Veregir	n et al.	<u></u>	526/219.3		
	D	US-							
	E	US-				·			
	F	US-							
	G	US-							
	Н	US-							
	1	US-							
	J	US-							
	К	US-						· · · · · · · · · · · · · · · · · · ·	
	L	US-							
	М	US-							
				FOREIGN	PATENT DO	CUMENTS		<u> </u>	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	(Country	Name		Classification	
	N	JP 2000212329 A	08-2000	Japan		ONOI et al.			
X	0	JP 10-182881 A	07-1998	Japan		Masayoshi et al.			
	Ρ								
	ø							<u> </u>	
	R							in the second se	
	s								
	Т						, et :		
	NON-PATENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
	٧								
	_ w _								
	X		*					•	